## Notice of References Cited Application/Control No. 09/830,222 Applicant(s)/Patent Under Reexamination MIURA ET AL. Examiner Xu Mei Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,990,443	01-2006	Abe et al.	704/222
*	В	US-2002/0172372	11-2002	Tagawa et al.	381/56
*	С	US-2006/0195322	08-2006	Broussard et al.	704/270
	D	US-			
	E	US-			
	F	US-			
6	G	US-			
	Н	US-	7. 14		
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				-	
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.